

## FEATURES

- High short circuit capability, self limiting short circuit current
- IGBT<sup>3</sup> CHIP (Trench+Field Stop technology)
- $V_{CE(sat)}$  with positive temperature coefficient
- Fast switching and short tail current
- Free wheeling diodes with fast and soft reverse recovery
- Low switching losses



## APPLICATIONS

- High frequency switching application
- Medical applications
- Motion/servo control
- UPS systems

## ABSOLUTE MAXIMUM RATINGS

$T_C=25^{\circ}\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Values	Unit
<b>IGBT</b>				
$V_{CES}$	Collector - Emitter Voltage	$T_{vj}=25^{\circ}\text{C}$	1200	V
$V_{GES}$	Gate - Emitter Voltage		$\pm 20$	V
$I_C$	DC Collector Current	$T_C=25^{\circ}\text{C}$	580	A
		$T_C=80^{\circ}\text{C}$	400	A
$I_{CM}$	Repetitive Peak Collector Current	$t_p=1\text{ms}$	800	A
$P_{tot}$	Power Dissipation Per IGBT		1925	W
<b>Diode</b>				
$V_{RRM}$	Repetitive Reverse Voltage	$T_{vj}=25^{\circ}\text{C}$	1200	V
$I_{F(AV)}$	Average Forward Current	$T_C=25^{\circ}\text{C}$	580	A
		$T_C=80^{\circ}\text{C}$	400	A
$I_{FRM}$	Repetitive Peak Forward Current	$t_p=1\text{ms}$	800	A
$I^2t$		$T_{vj}=125^{\circ}\text{C}, t=10\text{ms}, V_R=0\text{V}$	30000	$\text{A}^2\text{s}$

# MMG400D120UA6TN

## ELECTRICAL AND THERMAL CHARACTERISTICS $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<b>IGBT</b>						
$V_{GE(th)}$	Gate - Emitter Threshold Voltage	$V_{CE}=V_{GE}, I_C=16\text{mA}$	5.0	5.8	6.5	V
$V_{CE(sat)}$	Collector - Emitter Saturation Voltage	$I_C=400\text{A}, V_{GE}=15\text{V}, T_{Vj}=25^\circ\text{C}$		1.7		V
		$I_C=400\text{A}, V_{GE}=15\text{V}, T_{Vj}=125^\circ\text{C}$		1.9		V
$I_{CES}$	Collector Leakage Current	$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_{Vj}=25^\circ\text{C}$			2	mA
		$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_{Vj}=125^\circ\text{C}$			10	mA
$I_{GES}$	Gate Leakage Current	$V_{CE}=0\text{V}, V_{GE} \pm 15\text{V}, T_{Vj}=125^\circ\text{C}$	-400		400	nA
$R_{Gint}$	Integrated Gate Resistor			1.9		$\Omega$
$Q_{ge}$	Gate Charge	$V_{CE}=600\text{V}, I_C=400\text{A}, V_{GE}=\pm 15\text{V}$		3.8		$\mu\text{C}$
$C_{ies}$	Input Capacitance	$V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		28		nF
$C_{res}$	Reverse Transfer Capacitance			1.0		nF
$t_{d(on)}$	Turn - on Delay Time	$V_{CC}=600\text{V}, I_C=400\text{A}, T_{Vj}=25^\circ\text{C}$		160		ns
		$R_G=1.8\ \Omega, T_{Vj}=125^\circ\text{C}$		170		ns
$t_r$	Rise Time	$V_{GE}=\pm 15\text{V}, T_{Vj}=25^\circ\text{C}$		40		ns
		Inductive Load $T_{Vj}=125^\circ\text{C}$		45		ns
$t_{d(off)}$	Turn - off Delay Time	$V_{CC}=600\text{V}, I_C=400\text{A}, T_{Vj}=25^\circ\text{C}$		450		ns
		$R_G=1.8\ \Omega, T_{Vj}=125^\circ\text{C}$		520		ns
$t_f$	Fall Time	$V_{GE}=\pm 15\text{V}, T_{Vj}=25^\circ\text{C}$		100		ns
		Inductive Load $T_{Vj}=125^\circ\text{C}$		160		ns
$E_{on}$	Turn - on Energy	$V_{CC}=600\text{V}, I_C=400\text{A}, T_{Vj}=25^\circ\text{C}$		20		mJ
		$R_G=1.8\ \Omega, T_{Vj}=125^\circ\text{C}$		30		mJ
$E_{off}$	Turn - off Energy	$V_{GE}=\pm 15\text{V}, T_{Vj}=25^\circ\text{C}$		33		mJ
		Inductive Load $T_{Vj}=125^\circ\text{C}$		50		mJ
$I_{sc}$	Short Circuit Current	$t_{psc} \leq 10\ \mu\text{s}, V_{GE}=15\text{V}$ $T_{Vj}=125^\circ\text{C}, V_{CC}=900\text{V}$		1550		A
$R_{thJC}$	Junction-to-Case Thermal Resistance ( Per IGBT )				0.065	K/W
<b>Diode</b>						
$V_F$	Forward Voltage	$I_F=400\text{A}, V_{GE}=0\text{V}, T_{Vj}=25^\circ\text{C}$		1.65		V
		$I_F=400\text{A}, V_{GE}=0\text{V}, T_{Vj}=125^\circ\text{C}$		1.65		V
$I_{RRM}$	Max. Reverse Recovery Current	$I_F=400\text{A}, V_R=600\text{V}$		450		A
$Q_{rr}$	Reverse Recovery Charge	$di_F/dt=-8000\text{A}/\mu\text{s}$		75		$\mu\text{C}$
$E_{rec}$	Reverse Recovery Energy	$T_{Vj}=125^\circ\text{C}$		35		mJ
$R_{thJCD}$	Junction-to-Case Thermal Resistance ( Per Diode )				0.12	K/W

MODULE CHARACTERISTICS

$T_C=25^{\circ}\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$T_{Vj\ max}$	Max. Junction Temperature				150	$^{\circ}\text{C}$
$T_{Vj\ op}$	Operating Temperature		-40		125	$^{\circ}\text{C}$
$T_{stg}$	Storage Temperature		-40		125	$^{\circ}\text{C}$
$V_{isol}$	Insulation Test Voltage	AC, t=1min		3000		V
CTI	Comparative Tracking Index		350			
Torque	Module-to-Sink	Recommended (M6)	3		5	N · m
Torque	Module Electrodes	Recommended (M6)	2.5		5	N · m
Weight				320		g

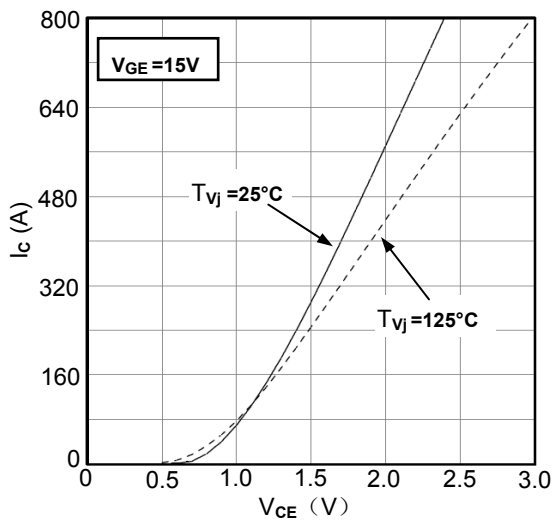


Figure1. Typical Output Characteristics

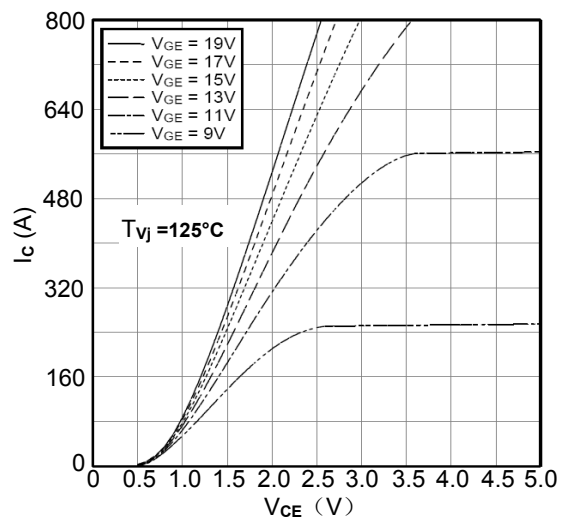


Figure2. Typical Output Characteristics

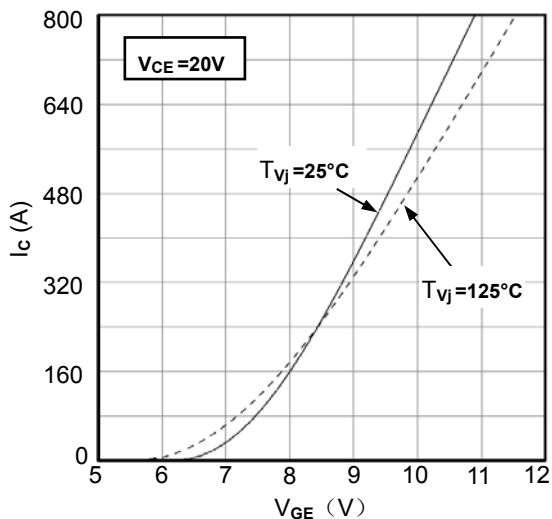


Figure3. Typical Transfer characteristics

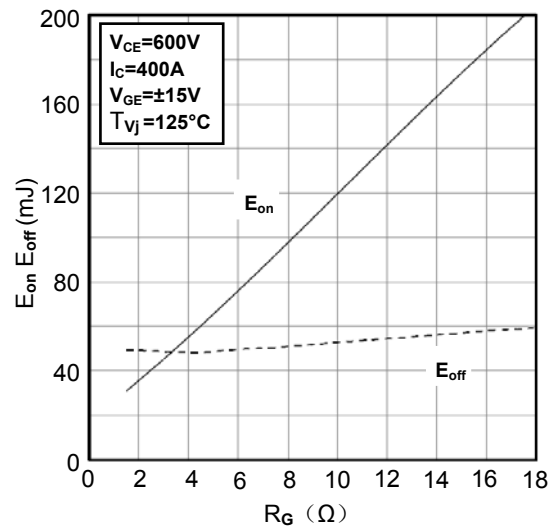


Figure4. Switching Energy vs. Gate Resistor

**MMG400D120UA6TN**

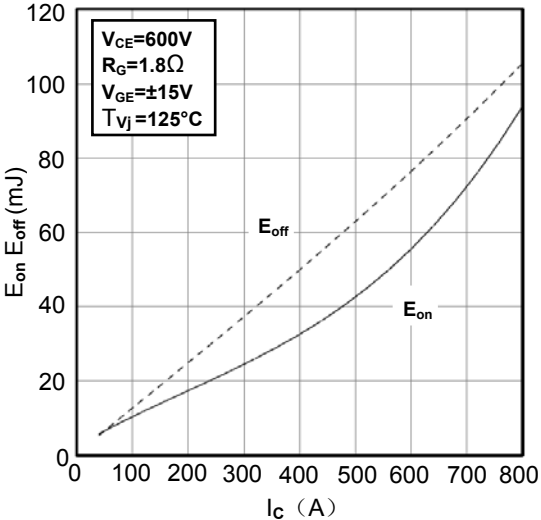


Figure5. Switching Energy vs. Collector Current

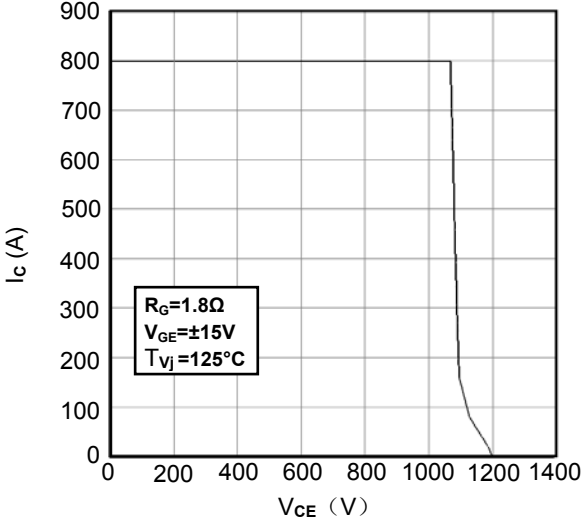


Figure6. Reverse Biased Safe Operating Area

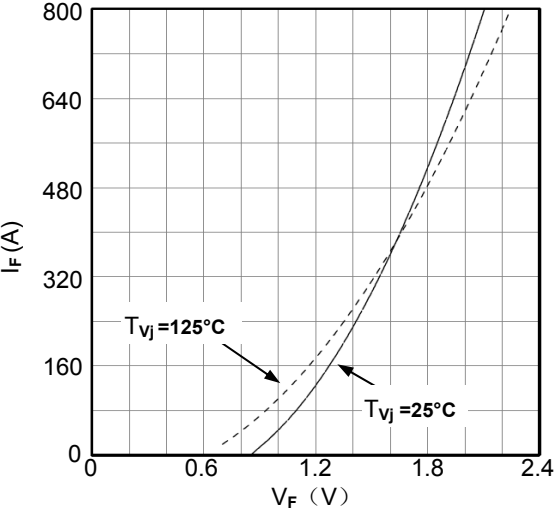


Figure7. Diode Forward Characteristics

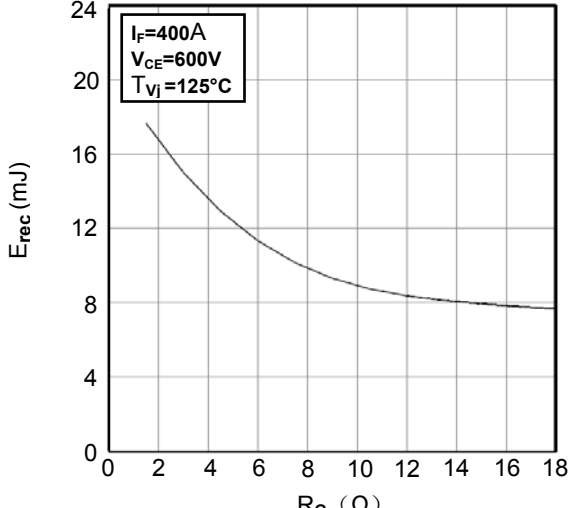


Figure8. Switching Energy vs. Gate Resistor

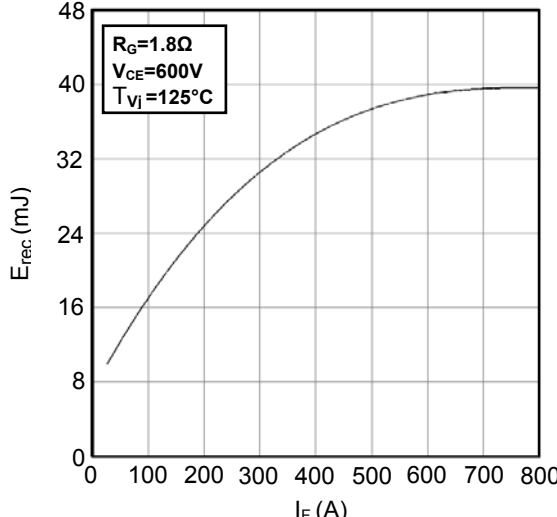


Figure9. Switching Energy vs. Forward Current

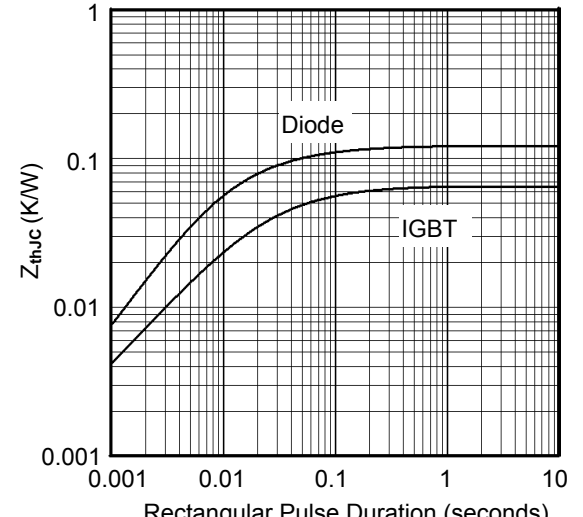


Figure10. Transient Thermal Impedance

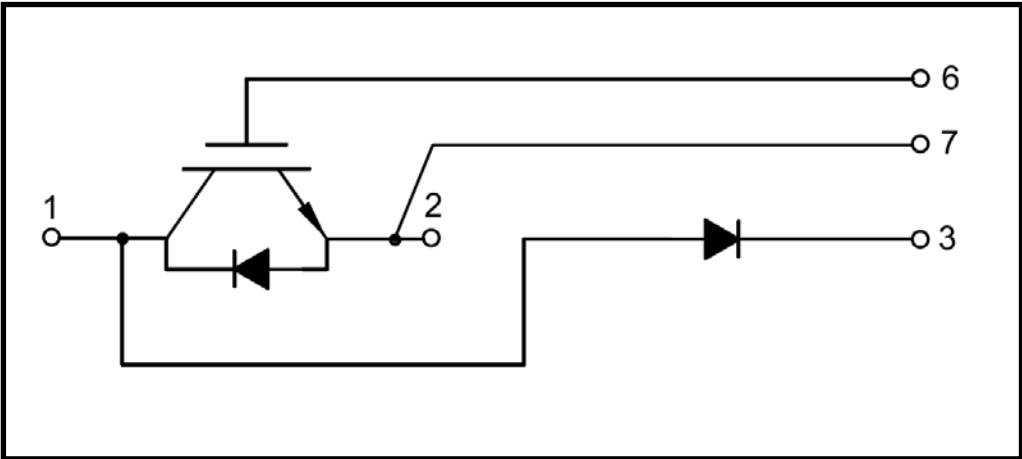
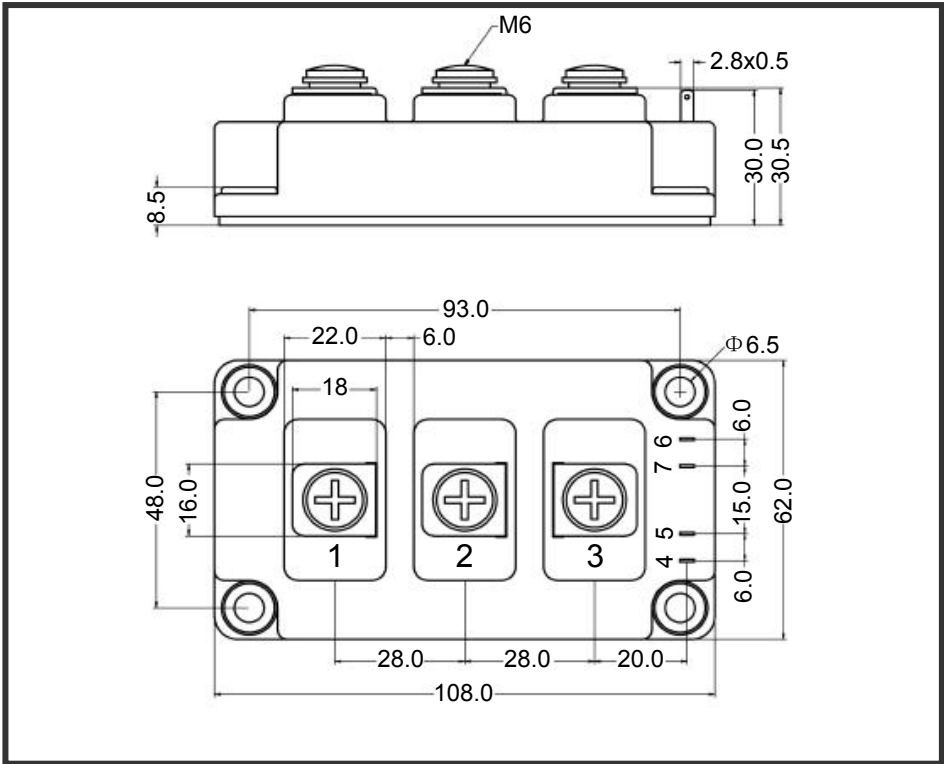


Figure11. Circuit Diagram



Dimensions (mm)  
Figure12. Package Outline